

**RESPONSE UNDER 37 C.F.R. § 1.116  
EXPEDITED PROCEDURE  
EXAMINING GROUP 2815**

Attorney Docket No. 5649-1276

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re: Young-pil Kim et al.

Serial No.: 10/796,672

Filed: March 9, 2004

For: SEMICONDUCTOR DEVICE TEST PATTERNS AND RELATED METHODS  
FOR PRECISELY MEASURING LEAKAGE CURRENTS IN SEMICONDUCTOR  
CELL TRANSISTORS

Examiner: Matthew C. Landau

Group Art Unit: 2815

Confirmation No.: 3015

Date: April 20, 2007

Mail Stop AMENDMENT

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

**AMENDMENT**

Sir:

Applicants provide the present *Amendment* in response to the Office Action mailed January 23, 2007. It is not believed that an extension of time and/or additional fee(s), including fees for net addition of claims-are required, beyond those that may otherwise be provided for in documents accompanying this paper. In the event, however, that an extension of time is necessary to allow consideration of this paper, such an extension is hereby petitioned under 37 C.F.R. §1.136(a). Any additional fees believed to be due in connection with this paper may be charged to our Deposit Account No. 50-0220.